## Applicant(s)/Patent Under Application/Control No. Reexamination 10/611,598 VAN BREE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1651 Francisco C. Prats **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В C US-US-D Ε US-US-F US-G US-Н USı J US-K US-L US-US-FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U Williams et al (Birth Defects: Original Article Series, Vol. XVI, No. 1, pages 415-423 (1980)) ٧ W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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